

SI2302DS

N-channel enhancement mode field-effect transistor

Rev. 02 — 20 November 2001

Product data

1. Description

N-channel enhancement mode field-effect transistor in a plastic package using TrenchMOS™¹ technology.

Product availability:

SI2302DS in SOT23.

2. Features

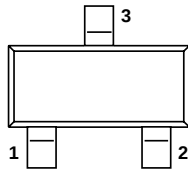
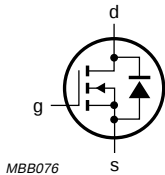
- TrenchMOS™ technology
- Very fast switching
- Logic level compatible
- Subminiature surface mount package.

3. Applications

- Battery management
- High speed switch
- Low power DC to DC converter.

4. Pinning information

Table 1: Pinning - SOT23, simplified outline and symbol

Pin	Description	Simplified outline	Symbol
1	gate (g)	 Top view MSB003	 MBB076
2	source (s)		
3	drain (d)		
		SOT23	

1. TrenchMOS is a trademark of Koninklijke Philips Electronics N.V.



PHILIPS

5. Quick reference data

Table 2: Quick reference data

Symbol	Parameter	Conditions	Typ	Max	Unit
V_{DS}	drain-source voltage (DC)	$T_j = 25$ to 150 °C	–	20	V
I_D	drain current (DC)	$T_{sp} = 25$ °C; $V_{GS} = 4.5$ V	–	2.5	A
P_{tot}	total power dissipation	$T_{sp} = 25$ °C	–	0.83	W
T_j	junction temperature		–	150	°C
$R_{DS(on)}$	drain-source on-state resistance	$V_{GS} = 4.5$ V; $I_D = 3.6$ A	56	85	mΩ
		$V_{GS} = 2.5$ V; $I_D = 3.1$ A	77	115	mΩ

6. Limiting values

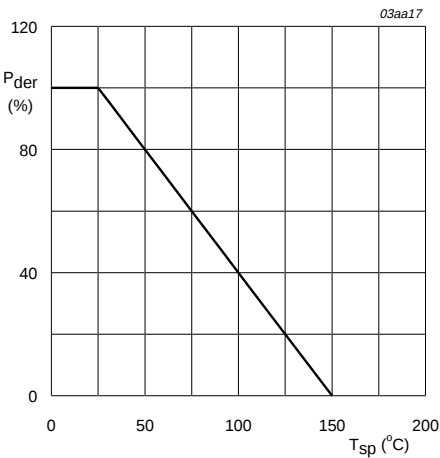
Table 3: Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
V_{DS}	drain-source voltage (DC)	$T_j = 25$ to 150 °C	–	20	V
V_{GS}	gate-source voltage (DC)		–	±8	V
I_D	drain current (DC)	$T_{sp} = 25$ °C; $V_{GS} = 4.5$ V; Figure 2 and 3	–	2.5	A
		$T_{sp} = 70$ °C; $V_{GS} = 4.5$ V; Figure 2	–	2	A
I_{DM}	peak drain current	$T_{sp} = 25$ °C; pulsed; $t_p \leq 10$ μs; Figure 3	–	10	A
P_{tot}	total power dissipation	$T_{sp} = 25$ °C; Figure 1	–	0.83	W
T_{stg}	storage temperature		–65	+150	°C
T_j	operating junction temperature		–65	+150	°C

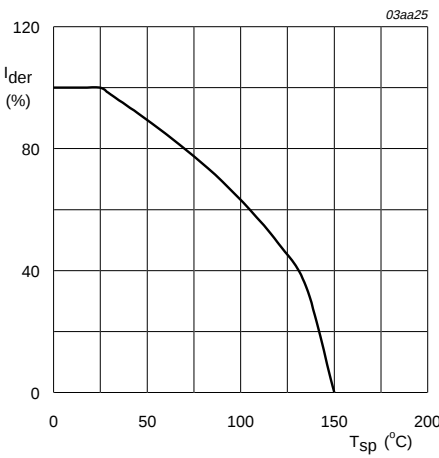
Source-drain diode

I_S	source (diode forward) current (DC)	$T_{sp} = 25$ °C	–	0.7	A
-------	-------------------------------------	------------------	---	-----	---



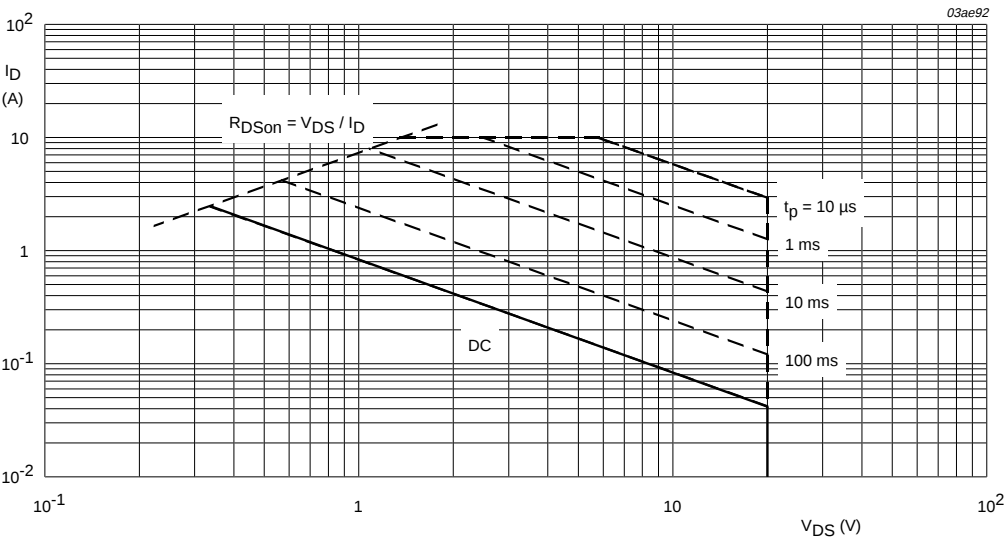
$$P_{der} = \frac{P_{tot}}{P_{tot(25^{\circ}C)}} \times 100\%$$

Fig 1. Normalized total power dissipation as a function of solder point temperature.



$$I_{der} = \frac{I_D}{I_{D(25^{\circ}C)}} \times 100\%$$

Fig 2. Normalized continuous drain current as a function of solder point temperature.



$T_{sp} = 25^{\circ}C$; I_{DM} is single pulse.

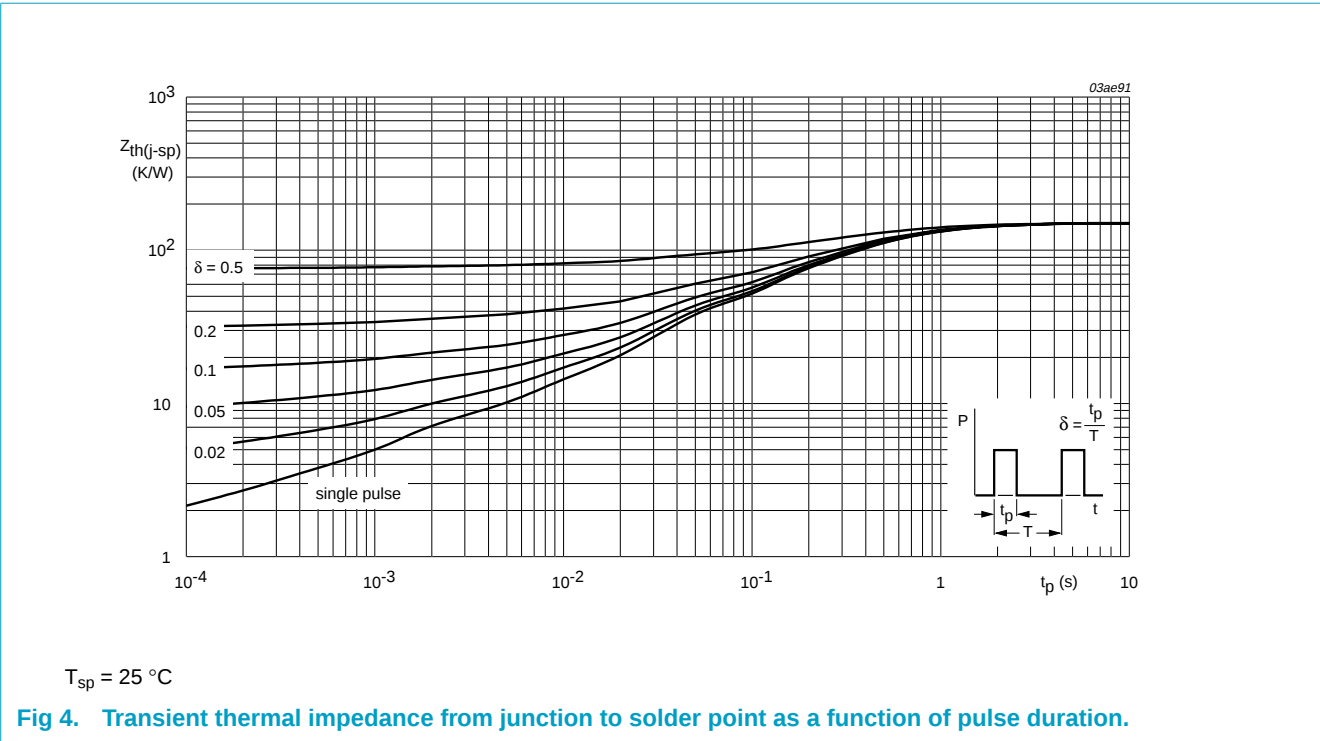
Fig 3. Safe operating area; continuous and peak drain currents as a function of drain-source voltage.

7. Thermal characteristics

Table 4: Thermal characteristics

Symbol	Parameter	Conditions	Value	Unit
$R_{th(j-sp)}$	thermal resistance from junction to solder point	mounted on a metal clad substrate; Figure 4	150	K/W

7.1 Transient thermal impedance

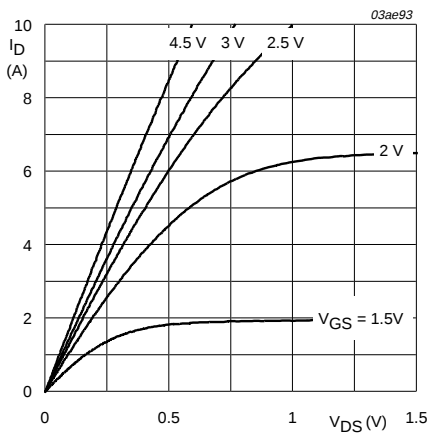


8. Characteristics

Table 5: Characteristics

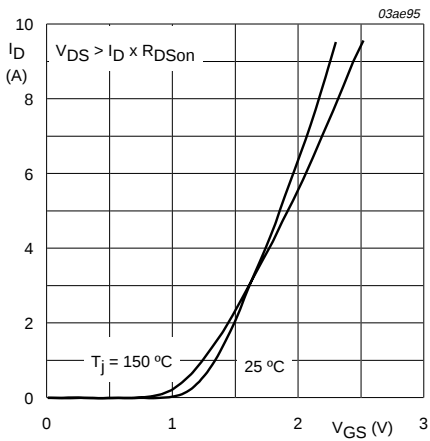
$T_j = 25\text{ }^{\circ}\text{C}$ unless otherwise specified

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
Static characteristics						
V _{(BR)DSS}	drain-source breakdown voltage	I _D = 10 μA; V _{GS} = 0 V	20	–	–	V
V _{GS(th)}	gate-source threshold voltage	I _D = 1 mA; V _{DS} = V _{GS} ; Figure 9	0.65	–	–	V
I _{DSS}	drain-source leakage current	V _{DS} = 20 V; V _{GS} = 0 V				
		T _j = 25 °C	–	0.01	1.0	μA
		T _j = 55 °C	–	–	10	μA
I _{GSS}	gate-source leakage current	V _{GS} = ±8 V; V _{DS} = 0 V	–	10	100	nA
R _{DSon}	drain-source on-state resistance	V _{GS} = 4.5 V; I _D = 3.6 A; Figure 7 and 8	–	56	85	mΩ
		V _{GS} = 2.5 V; I _D = 3.1 A; Figure 7 and 8	–	77	115	mΩ
Dynamic characteristics						
g _{fs}	forward transconductance	V _{DS} = 5 V; I _D = 3.6 A	–	8	–	S
Q _{g(tot)}	total gate charge	V _{DD} = 10 V; V _{GS} = 4.5 V; I _D = 3.6 A; Figure 13	–	5.4	10	nC
Q _{gs}	gate-source charge		–	0.65	–	nC
Q _{gd}	gate-drain (Miller) charge		–	1.6	–	nC
C _{iss}	input capacitance	V _{GS} = 0 V; V _{DS} = 10 V; f = 1 MHz; Figure 11	–	230	–	pF
C _{oss}	output capacitance		–	125	–	pF
C _{rss}	reverse transfer capacitance		–	80	–	pF
t _{d(on)}	turn-on delay time	V _{DD} = 10 V; R _L = 5.5 Ω; V _{GS} = 4.5 V; R _G = 6 Ω	–	12	20	ns
t _r	rise time		–	23	35	ns
t _{d(off)}	turn-off delay time		–	50	100	ns
t _f	fall time		–	34	50	ns
Source-drain diode						
V _{SD}	source-drain (diode forward) voltage	I _S = 1.6 A; V _{GS} = 0 V; Figure 12	–	0.8	1.2	V



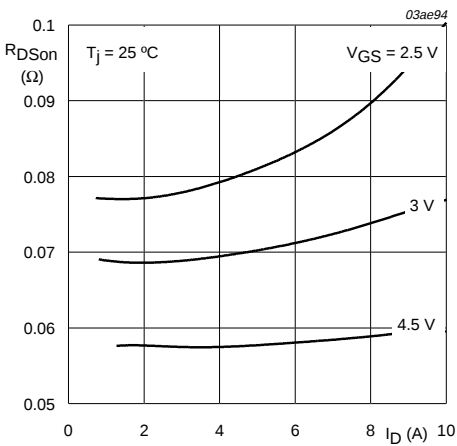
$T_j = 25\text{ }^{\circ}\text{C}$

Fig 5. Output characteristics: drain current as a function of drain-source voltage; typical values.



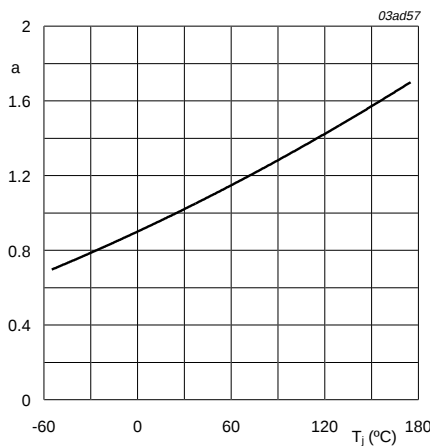
$T_j = 25\text{ }^{\circ}\text{C}$ and $150\text{ }^{\circ}\text{C}$; $V_{DS} > I_D \times R_{DSon}$

Fig 6. Transfer characteristics: drain current as a function of gate-source voltage; typical values.



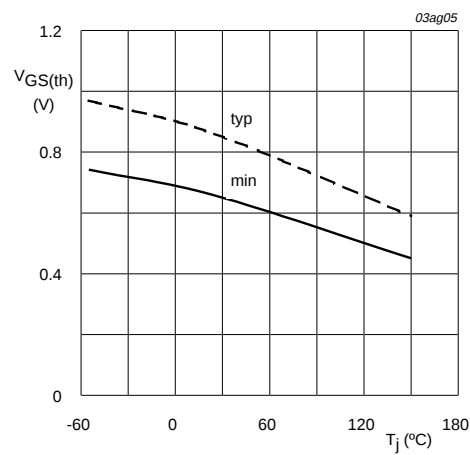
$T_j = 25\text{ }^{\circ}\text{C}$

Fig 7. Drain-source on-state resistance as a function of drain current; typical values.



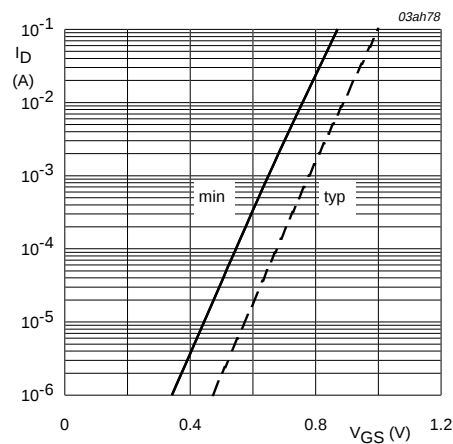
$$a = \frac{R_{DSon}}{R_{DSon(25^{\circ}\text{C})}}$$

Fig 8. Normalized drain-source on-state resistance factor as a function of junction temperature.



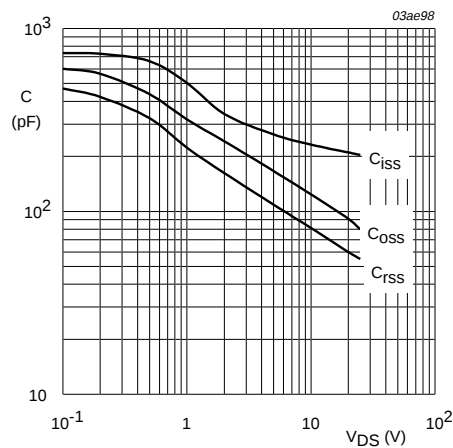
$I_D = 1 \text{ mA}$; $V_{DS} = V_{GS}$

Fig 9. Gate-source threshold voltage as a function of junction temperature.



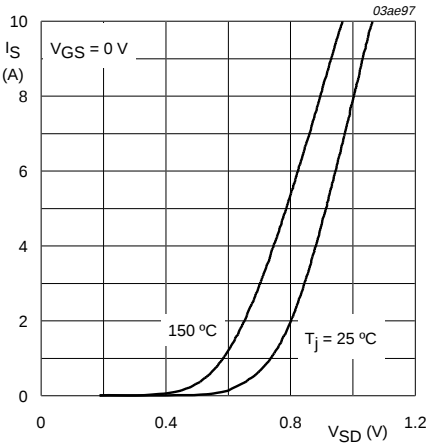
$T_J = 25 \text{ }^\circ\text{C}$; $V_{DS} = 5 \text{ V}$

Fig 10. Sub-threshold drain current as a function of gate-source voltage.



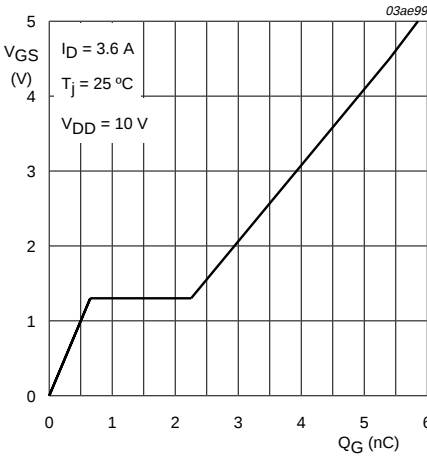
$V_{GS} = 0 \text{ V}$; $f = 1 \text{ MHz}$

Fig 11. Input, output and reverse transfer capacitances as a function of drain-source voltage; typical values.



$T_J = 25$ °C and 150 °C; $V_{GS} = 0$ V

Fig 12. Source (diode forward) current as a function of source-drain (diode forward) voltage; typical values.



$I_D = 3.6$ A; $V_{DD} = 10$ V

Fig 13. Gate-source voltage as a function of gate charge; typical values.

9. Package outline

Plastic surface mounted package; 3 leads

SOT23

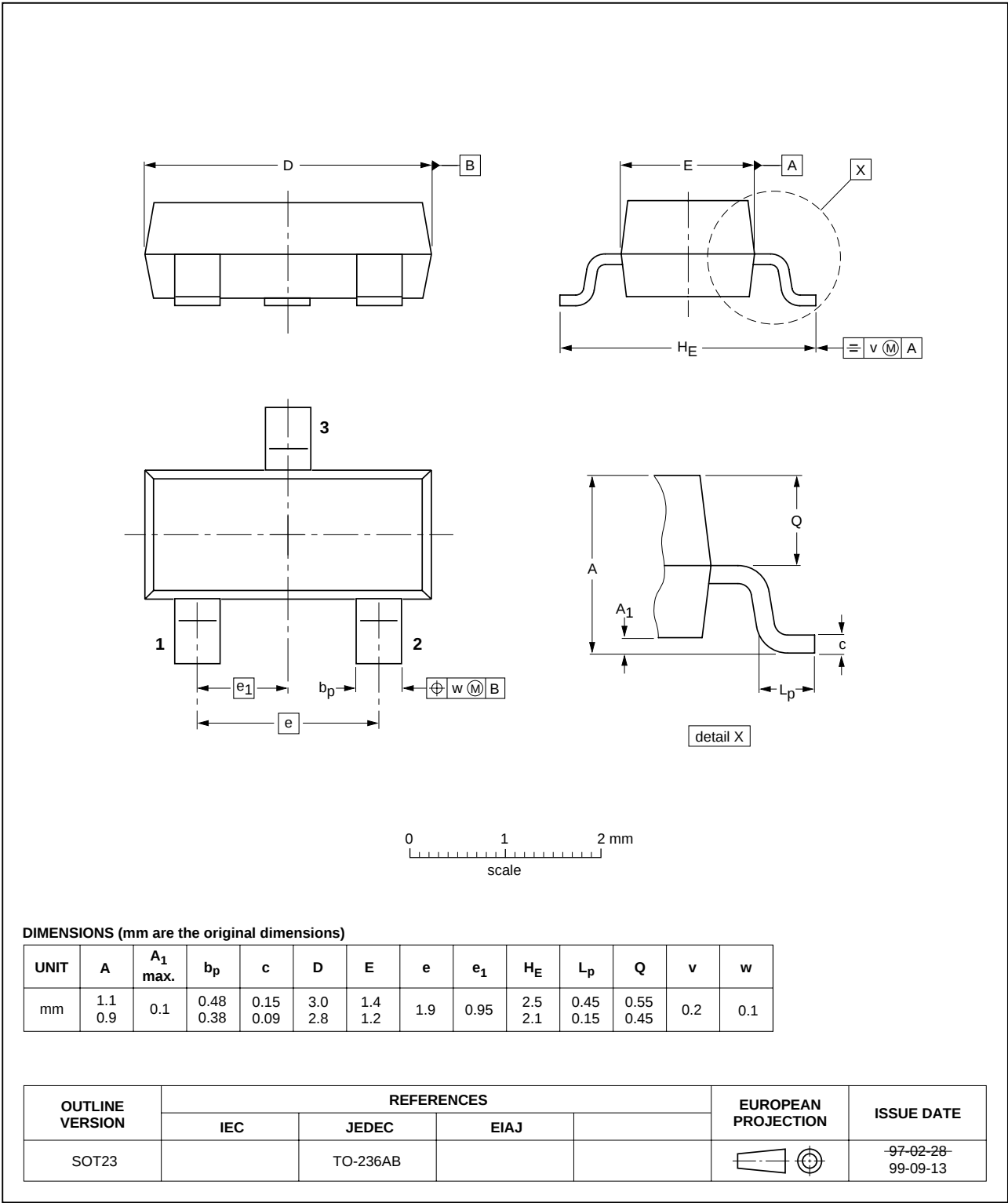


Fig 14. SOT23.

10. Revision history

Table 6: Revision history

Rev	Date	CPCN	Description
02	20011120	-	Includes product data; second version; supersedes initial version 03 september 2001. • Table 5 "Characteristics" Correction to $V_{GS(th)}$ conditions. • Figure 9 Correction to curves. • Figure 10 Correction to curves.
01	20010903	-	Product specification; initial version.

11. Data sheet status

Data sheet status ^[1]	Product status ^[2]	Definition
Objective data	Development	This data sheet contains data from the objective specification for product development. Philips Semiconductors reserves the right to change the specification in any manner without notice.
Preliminary data	Qualification	This data sheet contains data from the preliminary specification. Supplementary data will be published at a later date. Philips Semiconductors reserves the right to change the specification without notice, in order to improve the design and supply the best possible product.
Product data	Production	This data sheet contains data from the product specification. Philips Semiconductors reserves the right to make changes at any time in order to improve the design, manufacturing and supply. Changes will be communicated according to the Customer Product/Process Change Notification (CPCN) procedure SNW-SQ-650A.

[1] Please consult the most recently issued data sheet before initiating or completing a design.

[2] The product status of the device(s) described in this data sheet may have changed since this data sheet was published. The latest information is available on the Internet at URL <http://www.semiconductors.philips.com>.

12. Definitions

Short-form specification — The data in a short-form specification is extracted from a full data sheet with the same type number and title. For detailed information see the relevant data sheet or data handbook.

Limiting values definition — Limiting values given are in accordance with the Absolute Maximum Rating System (IEC 60134). Stress above one or more of the limiting values may cause permanent damage to the device. These are stress ratings only and operation of the device at these or at any other conditions above those given in the Characteristics sections of the specification is not implied. Exposure to limiting values for extended periods may affect device reliability.

Application information — Applications that are described herein for any of these products are for illustrative purposes only. Philips Semiconductors make no representation or warranty that such applications will be suitable for the specified use without further testing or modification.

13. Disclaimers

Life support — These products are not designed for use in life support appliances, devices, or systems where malfunction of these products can reasonably be expected to result in personal injury. Philips Semiconductors customers using or selling these products for use in such applications do so at their own risk and agree to fully indemnify Philips Semiconductors for any damages resulting from such application.

Right to make changes — Philips Semiconductors reserves the right to make changes, without notice, in the products, including circuits, standard cells, and/or software, described or contained herein in order to improve design and/or performance. Philips Semiconductors assumes no responsibility or liability for the use of any of these products, conveys no licence or title under any patent, copyright, or mask work right to these products, and makes no representations or warranties that these products are free from patent, copyright, or mask work right infringement, unless otherwise specified.

Contact information

For additional information, please visit <http://www.semiconductors.philips.com>.

For sales office addresses, send e-mail to: sales.addresses@www.semiconductors.philips.com.

Fax: +31 40 27 24825

Contents

1 Description 1

2 Features 1

3 Applications 1

4 Pinning information 1

5 Quick reference data 2

6 Limiting values 2

7 Thermal characteristics 4

7.1 Transient thermal impedance 4

8 Characteristics 5

9 Package outline 9

10 Revision history 10

11 Data sheet status 11

12 Definitions 11

13 Disclaimers 11

